Notice of References Cited

Application/Control No.

10/015,886

Examiner

Aravind K Moorthy

Applicant(s)/Patent Under Reexamination VLCAN ET AL.

Art Unit
Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,050,212	09-1991	Dyson, Patrick	713/187
	В	US-5,530,757	06-1996	Krawczyk, Hugo M.	713/188
	С	US-5,694,569	12-1997	Fischer, Addison M.	711/216
	D	US-5,909,429	06-1999	Satyanarayana et al.	370/254
	E	US-5,991,760	11-1999	Gauvin et al.	707/10
	F	US-6,049,612	04-2000	Fielder et al.	380/44
	G	US-6,085,266	07-2000	Cotugno, Lauren Ann	710/68
	Н	US-6,088,747	07-2000	Cotugno et al.	710/74
	ı	US-6,233,687 B1	05-2001	White, Gerry	713/201
	j	US-6,430,608 B1	08-2002	Shaio, Sami	709/217
	К	US-6,460,055 B1	10-2002	Midgley et al.	707/204
	L	US-6,532,527 B2	03-2003	Selkirk et al.	711/203
	М	US-6,618,735 B1	09-2003	Krishnaswami et al.	707/203

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					-
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jaeger et al, Preserving Integrity in Remote File Location and Retrieval, 1996, IEEE, pages 53-63
	V	Okamoto, Takeshi, A Distributed Approach to Computer Virus Detection and Neutralization by Autonomous and Heterogenous Agents, 1999, IEEE, pages 328-331
	w	Shintani et al, Hash Based Parallel Algorithms for Mining Association Rules, 1999, IEEE, pages 19-30
	х	Spitzner, Lance, What is MD5 and why should I care?, August 1999, Inside Solaris, page 15

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 20040616

Notice of References Cited

Application/Control No.

10/015,886

Examiner

Aravind K Moorthy

Applicant(s)/Patent Under
Reexamination
VLCAN ET AL.

Art Unit
Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,665,659 B1	12-2003	Logan, James D.	707/3
	В	US-6,694,434 B1	02-2004	McGee et al.	713/189
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Baykal et al, On the use of Hash Functions for Defect Detection in Textures for In-camera Web inspection Systems, 2002, IEEE pages 26-29
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 20040616